

FKBA4903

**N&P Channel Enhancement-Mode MOSFET**

Revision: A

**General Description**

Advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and low operation voltage. This device is suitable for using as a load switch or in PWM applications.

- Low  $R_{DS(on)}$
- Small Package Outline
- ESD protected

**Features**

For N-Channel MOSFET

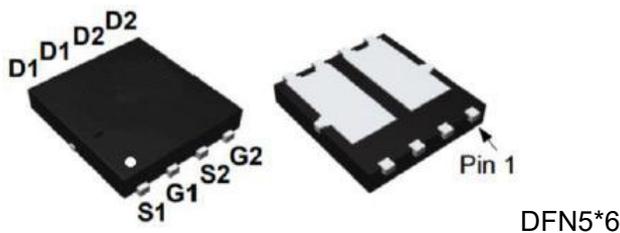
- $V_{DS} = 40V$
- $R_{DS(ON)} = 25m\Omega @ V_{GS}=10V$

For P-Channel MOSFET

- $V_{DS} = -40V$
- $R_{DS(ON)} = 30m\Omega @ V_{GS}=-10V$

**Pin configurations**

See Diagram below



**Absolute Maximum Ratings**

Parameter		Symbol	N-Channel	P-Channel	Units
Drain-Source Voltage		$V_{DS}$	40	-40	V
Gate-Source Voltage		$V_{GS}$	$\pm 20$	$\pm 20$	V
Drain Current	Continuous	$I_D$	26	-25	A
	Pulsed		47	-46	
Total Power Dissipation	@TA=25°C	$P_D$	35.7	35.7	W
Operating Junction Temperature Range		$T_J$	-55 to 150		°C

**Thermal Resistance**

Parameter	Symbol	N-Channel		P-Channel		Units
		Typ	Max	Typ	Max	
Thermal Resistance from Junction to Ambient	$R_{\theta JA}$		62		62	°C/W

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<b>N-Channel Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)</b>						
<b>Symbol</b>	<b>Parameter</b>	<b>Test Conditions</b>	<b>Min</b>	<b>Typ</b>	<b>Max</b>	<b>Units</b>
<b>OFF CHARACTERISTICS</b>						
B <sub>VDS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA,	40			V
I <sub>DSS</sub>	Drain to Source Leakage Current	V <sub>DS</sub> =32V, V <sub>GS</sub> =0V			1.0	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> =20 V			100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250μA	1.0	1.5	2.5	V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =12A		25	30	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =10A		30	50	mΩ
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =12A		8		S
<b>DYNAMIC PARAMETERS</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz		593		pF
C <sub>oss</sub>	Output Capacitance			76		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			56		pF
<b>SWITCHING PARAMETERS</b>						
Q <sub>g</sub>	Total Gate Charge <sup>2</sup>	V <sub>GS</sub> =4.5V, V <sub>DD</sub> =20V, I <sub>D</sub> =12A		5.5		nC
Q <sub>gs</sub>	Gate Source Charge			1.25		nC
Q <sub>gd</sub>	Gate Drain Charge			2.5		nC
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> =20V, R <sub>GEN</sub> =3.3Ω I <sub>D</sub> =1A		8.9		ns
t <sub>d(off)</sub>	Turn-Off Delay Time			41		ns
t <sub>d(r)</sub>	Turn-On Rise Time			2.2		ns
t <sub>d(f)</sub>	Turn-Off Fall Time			2.7		ns
<b>Source-Drain Diode Characteristics</b>						
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> =1A			1.2	V
I <sub>S</sub>	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V			23	A
I <sub>SM</sub>	Pulsed Source Current				46	A

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P-Channel Electrical Characteristics (T <sub>J</sub> =25°C unless otherwise noted)						
Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
<b>OFF CHARACTERISTICS</b>						
B <sub>V</sub> DSS	Drain-Source Breakdown Voltage	I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V	-40			V
I <sub>DSS</sub>	Drain to Source Leakage Current	V <sub>DS</sub> =-32V, V <sub>GS</sub> =0V			1	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> =20V			100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	-1		-2.5	V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =-10V, I <sub>D</sub> =-8A	-	30	45	mΩ
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-4A		55	70	mΩ
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =-5V, I <sub>D</sub> =-8A		12.6		S
<b>DYNAMIC PARAMETERS</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, f=1MHz		1004		pF
C <sub>oss</sub>	Output Capacitance			108		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			80		pF
<b>SWITCHING PARAMETERS</b>						
Q <sub>g</sub>	Total Gate Charge <sup>2</sup>	V <sub>GS</sub> =-4.5V, V <sub>DS</sub> =-20V, I <sub>D</sub> =-12A		9		nC
Q <sub>gs</sub>	Gate Source Charge			2.54		nC
Q <sub>gd</sub>	Gate Drain Charge			3.1		nC
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, R <sub>GEN</sub> =3.3Ω I <sub>D</sub> =-1A		19.2		ns
t <sub>d(off)</sub>	Turn-Off Delay Time			48.6		ns
t <sub>d(r)</sub>	Turn-On Rise Time			12.8		ns
t <sub>d(f)</sub>	Turn-Off Fall Time			4.6		ns
<b>Source-Drain Diode Characteristics</b>						
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> =-1A			-1	V
I <sub>S</sub>	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V			-20	A
I <sub>SM</sub>	Pulsed Source Current				-40	A

Typical Characteristics(N-Channel)

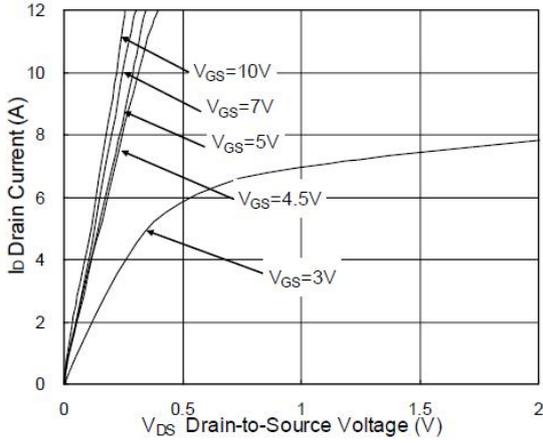


Fig.1 Typical Output Characteristics

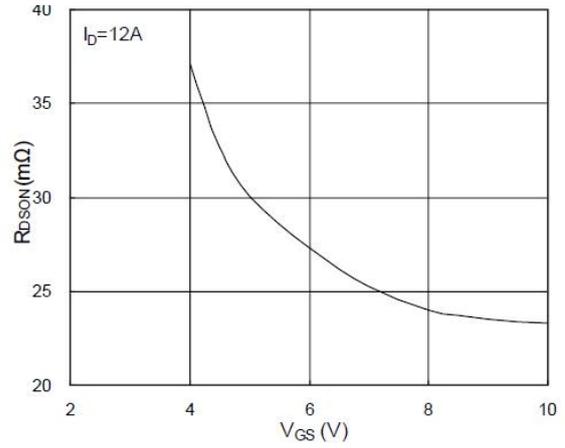


Fig.2 On-Resistance vs. G-S Voltage

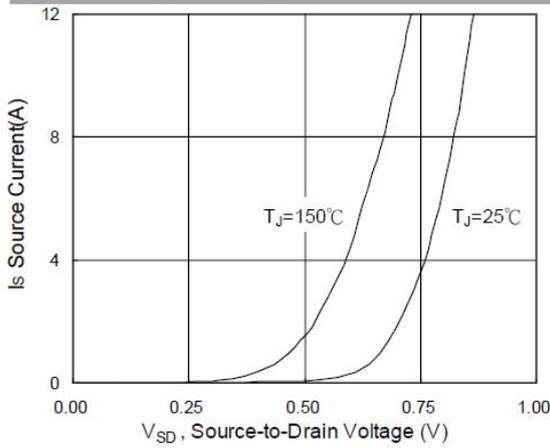


Fig.3 Forward Characteristics of Reverse

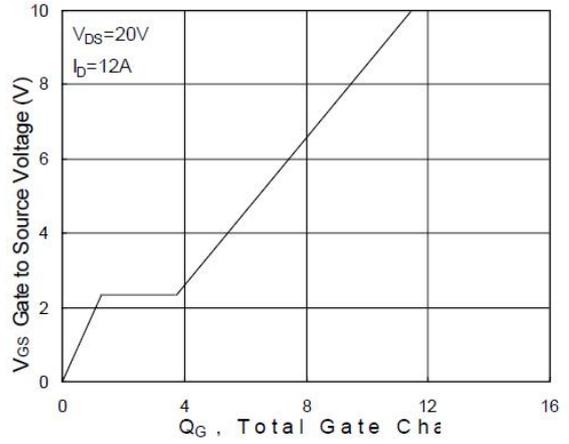


Fig.4 Gate-Charge Characteristics

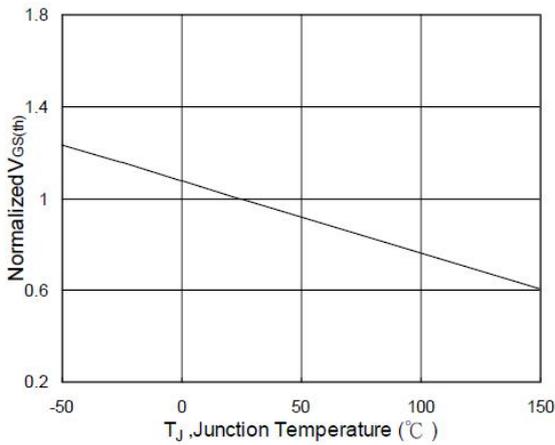


Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$

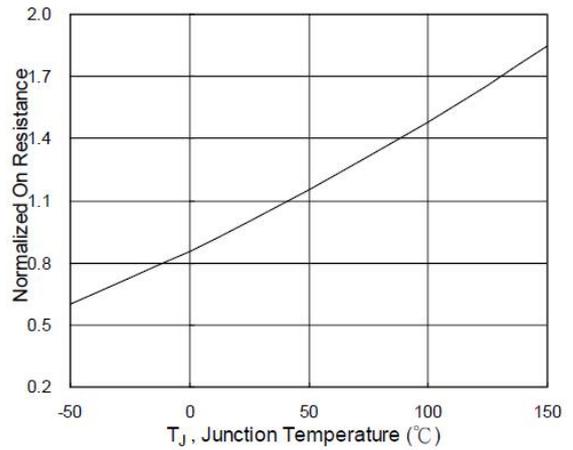


Fig.6 Normalized  $R_{DS(on)}$  vs.  $T_J$

Typical Characteristics(N-Channel)

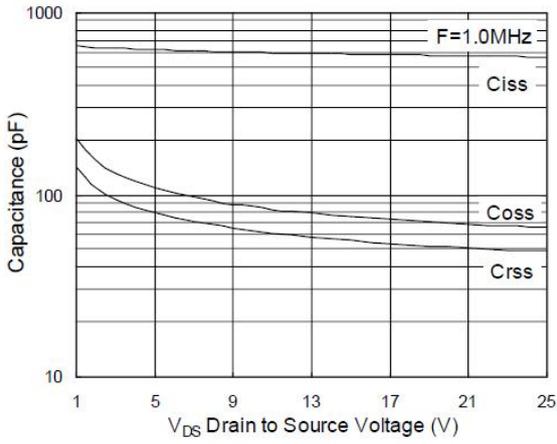


Fig.7 Capacitance

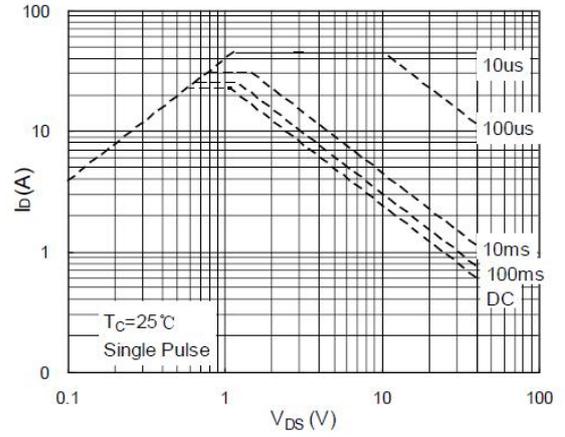


Fig.8 Safe Operating Area

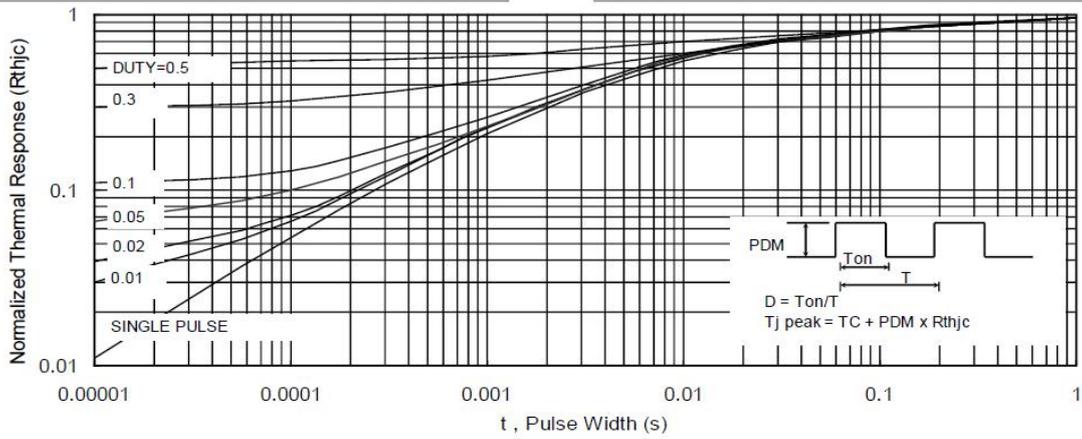


Fig.9 Normalized Maximum Transient Thermal Impedance

Typical Characteristics(P-Channel)

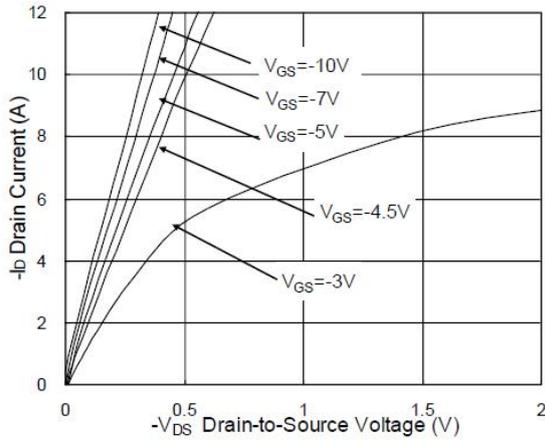


Fig.1 Typical Output Characteristics

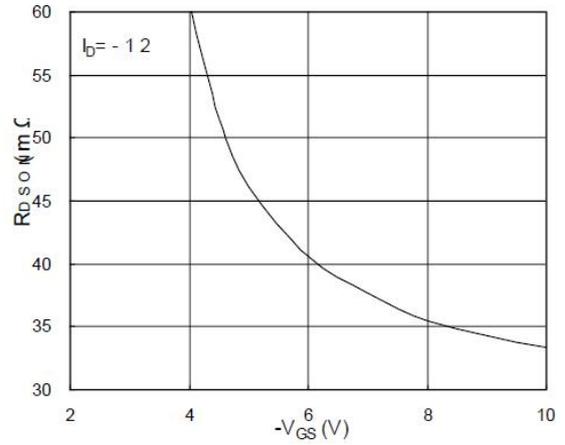


Fig.2 On-Resistance v.s Gate-Source

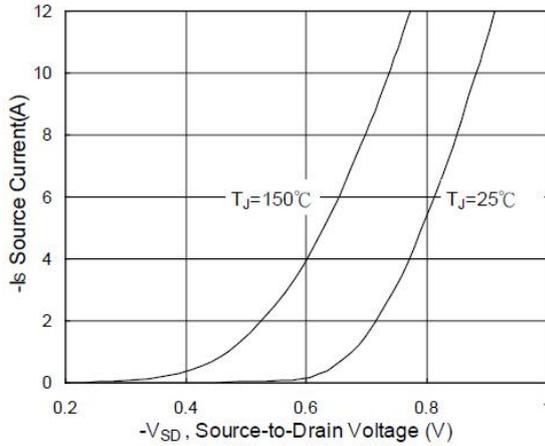


Fig.3 Forward Characteristics of Reverse

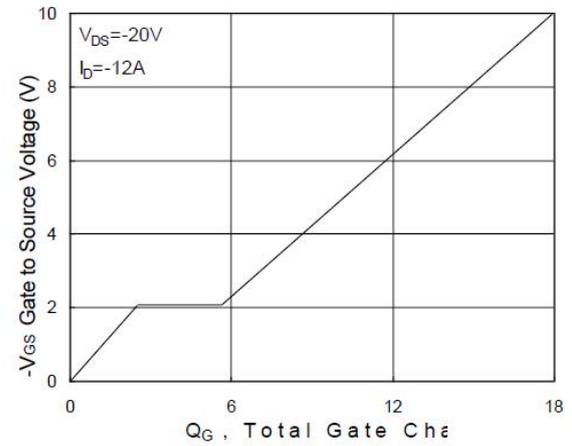


Fig.4 Gate-Charge Characteristics

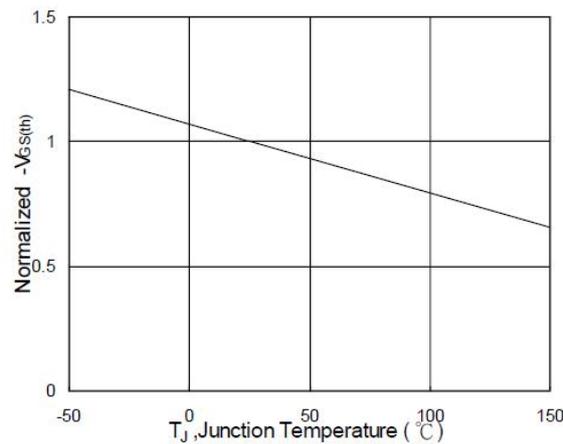


Fig.5 Normalized  $V_{GS(th)}$  v.s  $T_J$

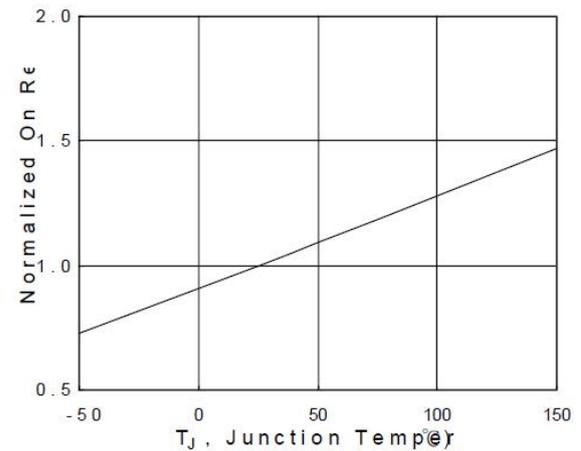


Fig.6 Normalized  $R_{DS(on)}$  v.s  $T_J$

Typical Characteristics(P-Channel)

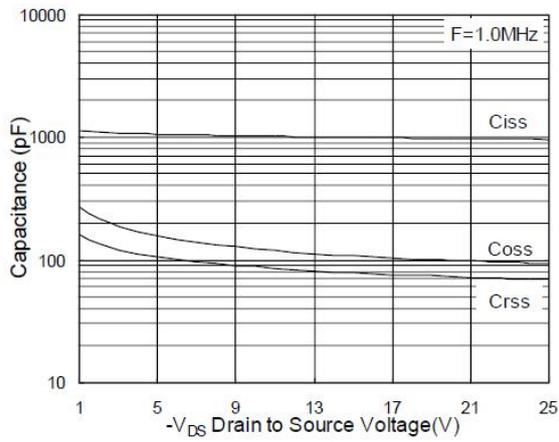


Fig.7 Capacitance

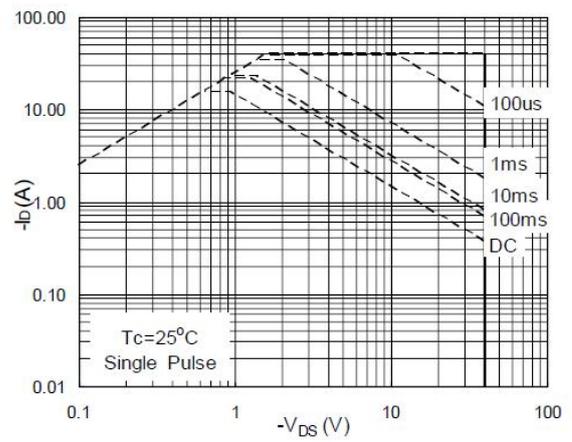


Fig.8 Safe Operating Area

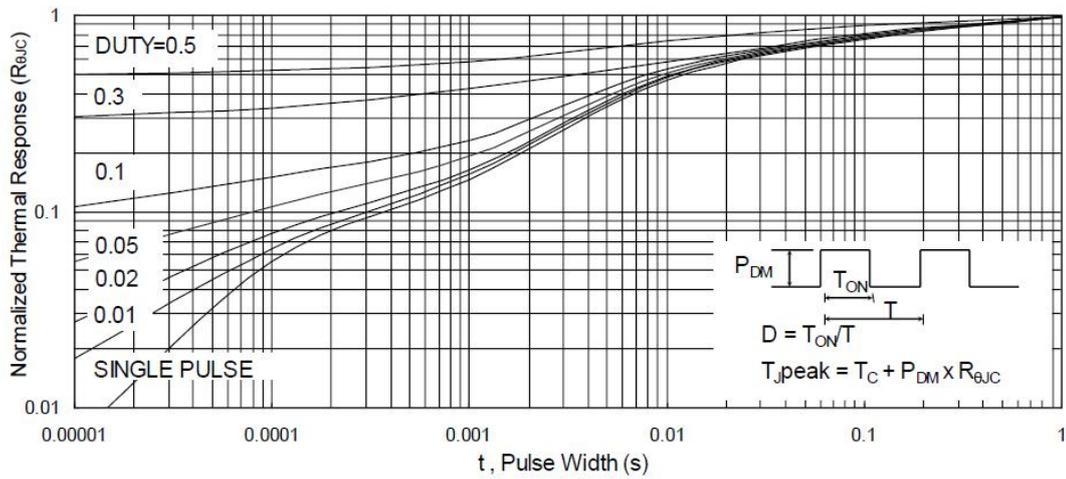


Fig.9 Normalized Maximum Transient Thermal Impedance

